

**Search Notes**


Application/Control No.

10/770,278

Examiner

Yennhu B. Huynh

 Applicant(s)/Patent under  
Reexamination

MOUMEN, NAIM

Art Unit

2813

**SEARCHED**

Class	Subclass	Date	Examiner
138	386	2/28/05	YN
	303		
	595		
	702		
	184		
	197		
	706		
	700		
	719		
	723		
	752	3/27/05	YFT
	585		
	269		MM
	=		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
D. east/west search USPAT EPO JPO Jewent IBM TDB	2/28/05	YFT
- Search w. Keyword consult. w. Primary ERICK JEELIN (attached)	2/28/05 3/25/05 3/27/05	YFT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
138	386	3/27/05	YFT
	269		YFT
	703		YFT